Search Notes



| Application/Control No. | Applicant(s)/Patent Under Reexamination |
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| 10662524 | NAKAYAMA ET AL. |
| Examiner | Art Unit |

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| SEARCHED | | | | | |
|----------|----------|------------|----------|--|--|
| Class | Subclass | Date | Examiner | | |
| 451 | 42-44 | 3/8/2006 | DVN | | |
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| 451 | 296 | 3/8/2006 | DVN | | |
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| | updated | 8/3/2006 | DVN | | |
| | updated | 11/17/2006 | DVN | | |

Nguyen, Dung V

| SEARCH NOTES | | | |
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| Search Notes | Date | Examiner | |
| See Search History | 3/8/2006 | DVN | |
| See Search History | 8/3/2006 | DVN | |
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| INTERFERENCE SEARCH | | | | | |
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| Class | Subclass | Date | Examiner | | |
| | See Search History | 11/17/2006 | DVN | | |

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